PD - 95202

IRF7402PbF

HEXFET<sup>®</sup> Power MOSFET

## International **ICR** Rectifier

- Generation V Technology
- Ultra Low On-Resistance
- N-Channel MOSFET
- Very Small SOIC Package
- Low Profile (<1.1mm)
- Available in Tape & Reel
- Fast Switching
- Lead-Free

#### Description

Fifth Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

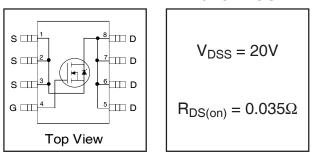
The SO-8 has been modified through a customized leadframe for enhanced thermal characterstics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infrared or wave soldering techniques. Power dissipation of greater than 0.8 W is possible in a typical PCB mount application.

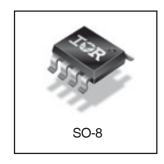
#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V	6.8	
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V	5.4	A
I <sub>DM</sub>	Pulsed Drain Current ①	54	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation	2.5	W
P <sub>D</sub> @T <sub>A</sub> = 70°C	Power Dissipation	1.6	
	Linear Derating Factor	0.02	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 12	V
dv/dt	Peak Diode Recovery dv/dt ②	5.0	V/ns
T <sub>J,</sub> T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to + 150	°C

#### Thermal Resistance

	Parameter	Max.	Units
R <sub>0JA</sub>	Maximum Junction-to-Ambient ④	50	°C/W





	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	20			V	$V_{GS} = 0V, I_D = 250 \mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.024		V/°C	Reference to $25^{\circ}$ C, $I_{D} = 1$ mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.035	Ω	$V_{GS} = 4.5V, I_D = 4.1A$ (3)
				0.050		$V_{GS} = 2.7V, I_D = 3.5A$ (3)
V <sub>GS(th)</sub>	Gate Threshold Voltage	0.70			V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
9 <sub>fs</sub>	Forward Transconductance	6.1			S	$V_{DS} = 10V, I_{D} = 1.9A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1.0	μA	$V_{DS} = 16V, V_{GS} = 0V$
	Drain-to-Source Leakage Current			25		$V_{DS} = 16V, V_{GS} = 0V, T_J = 125^{\circ}C$
lass	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 12V$
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -12V
Qg	Total Gate Charge		14	22		I <sub>D</sub> = 3.8A
Q <sub>gs</sub>	Gate-to-Source Charge		2.0	3.0	nC	V <sub>DS</sub> = 16V
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		6.3	9.5	†	$V_{GS}$ = 4.5V, See Fig. 6 and 12 $\ensuremath{\textcircled{3}}$
t <sub>d(on)</sub>	Turn-On Delay Time		5.1			V <sub>DD</sub> = 10V
tr	Rise Time		47		ns	I <sub>D</sub> = 3.8A
t <sub>d(off)</sub>	Turn-Off Delay Time		24		115	$R_{G} = 6.2\Omega$
t <sub>f</sub>	Fall Time		32			R <sub>D</sub> = 2.6Ω ③
C <sub>iss</sub>	Input Capacitance		650			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		300		pF	V <sub>DS</sub> = 15V
C <sub>rss</sub>	Reverse Transfer Capacitance		150			f = 1.0MHz, See Fig. 5

### Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

#### **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions																
I <sub>S</sub>	Continuous Source Current			0.5		MOSFET symbol																
	(Body Diode)		——	- 2.5		showing the																
I <sub>SM</sub>	Pulsed Source Current			54	54	<b>E</b> 4	<b>F</b> 4	<b>F</b> 4	54	4	<b>F</b> 4	<b>F</b> 4	<b>F</b> 4	<b>F</b> 4	4	<b>F</b> 4	<b>F</b> 4	<b>54</b>	<b>F</b> 4	<b>F</b> 4	A	integral reverse
	(Body Diode) ①	-				p-n junction diode.																
V <sub>SD</sub>	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C, I_S = 3.8A, V_{GS} = 0V$ (3)																
t <sub>rr</sub>	Reverse Recovery Time		51	77	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 3.8A																
Qrr	Reverse Recovery Charge		69	100	nC	di/dt = 100A/µs																

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- 3 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .
- G When mounted on 1 inch square copper board, t<10 sec
- ⑤ This data sheet has curves & data from IRF7601
- $@~I_{SD} \leq 3.8 \text{A},~di/dt \leq 96 \text{A}/\mu \text{s},~V_{DD} \leq V_{(BR)DSS},~T_J \leq 150^\circ\text{C}$

# International **IGR** Rectifier

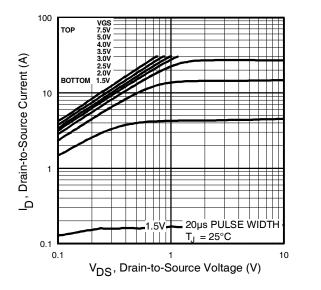


Fig 1. Typical Output Characteristics

Fig 3. Typical Transfer Characteristics

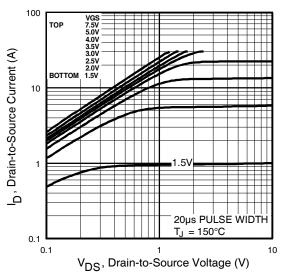


Fig 2. Typical Output Characteristics

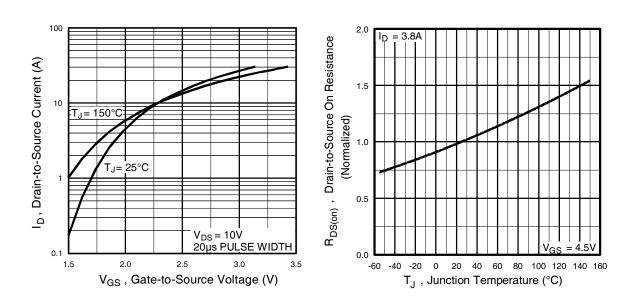


Fig 4. Normalized On-Resistance Vs. Temperature

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## International

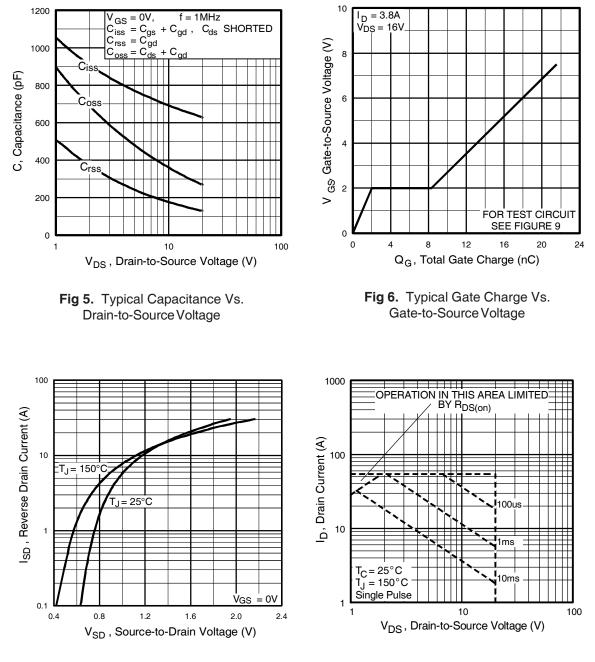
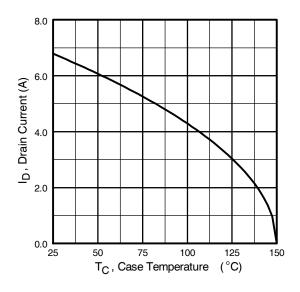
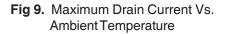


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

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## IRF7402PbF

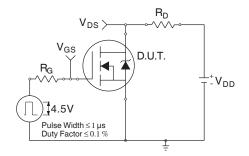


Fig 10a. Switching Time Test Circuit

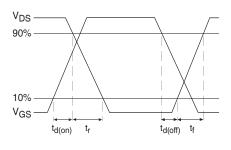


Fig 10b. Switching Time Waveforms

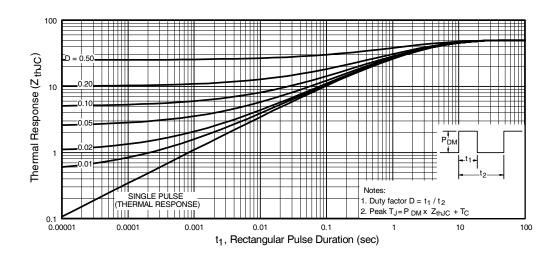


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

# International

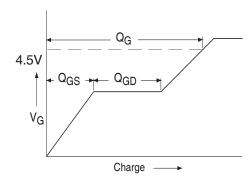
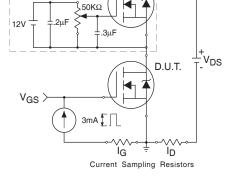


Fig 12a. Basic Gate Charge Waveform



Current Regulator Same Type as D.U.T.

Fig 12b. Gate Charge Test Circuit

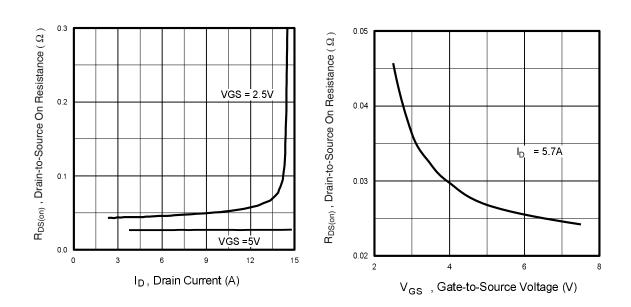


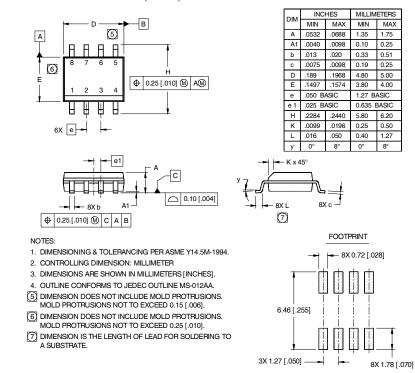
Fig 13. Typical On-Resistance Vs. Drain Current

Fig 14. Typical On-Resistance Vs. Gate Voltage

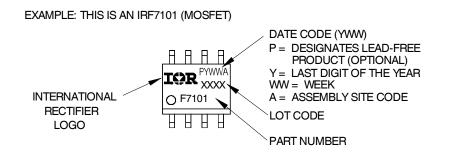
## International

### SO-8 Package Outline

Dimensions are shown in milimeters (inches)



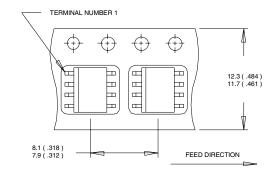
### SO-8 Part Marking Information (Lead-Free)



### International **TOR** Rectifier

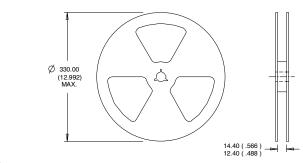
### SO-8 Tape and Reel

Dimensions are shown in milimeters (inches)



NOTES:

CONTROLLING DIMENSION : MILLIMETER.
ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES : 1. CONTROLLING DIMENSION : MILLIMETER. 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualifications Standards can be found on IR's Web site.

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